

Search Notes

Application/Control No.

09/788,036

Examiner

James D. Ewart

Applicant(s)/Patent under
Reexamination

FITCH ET AL.

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
455	404.2	4/10/2006	JDE
	414.2		
	414.3		
	414.4		
	456.1		
	456.2		
	456.3		
	456.4		
	456.5		
	456.6		
	443		
	444		
	446		
	457		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
same as	above	4/10/2006	JDE